

Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/003,653	YAMADA ET AL.
Examiner	Art Unit	
Christina Y. Leung	2633	

ISSUE CLASSIFICATION

ORIGINAL			CROSS REFERENCE(S)								
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)								
398	50	398	48								
INTERNATIONAL CLASSIFICATION											
H	0	4	J	14/00							
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				/							

Elynnia Young 5-16-05

(Assistant Examiner) (Date)

Total Claims Allowed: 4

Sharon West 5/18/05
(Legal Instruments Examiner) (Date)

JASON CHAN
SUPERVISORY PATENT EXAMINER
(Primary Examiner) (Date)
TECHNOLOGY CENTER 2600

O.G.
Print Claim(s)

O.G.
Print Fig.

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<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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